

	Application/Control No.	Applicant(s)/Patent under Reexamination	
٠	10/816,435	TSAO ET AL.	
	Examiner	Art Unit	
	Gonal C. Ray	2111	

	SEARCHED					
Class	Subclass	Date	Examiner			
710	260- 269,48,50, 73	3/3/2006	GCR			
719	318	3/3/2006	GCR			
709	253	3/3/2006	GCR			
712	25	3/3/2006	GCR			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
·	DATE	EXMR		
WEST: US PGPUB, USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	3/2/2006	GCR		
EAST: USPT (see search history printouts)	3/2/2006	GCR		
NPL: IEEE Xptore (see search history printouts)	3/2/2006	GCR		